### **INFORMATION DISCLOSURE** STATEMENT BY APPLICANT

Substitute for form 1449/PTO

Complete if Known Application Number NEW APPLICATION Filing Date HEREWITH First Named Inventor Milan R. Kokta Attorney Docket Number 1035-BI3918-CIP

Sheet 1 of 3 (use as many sheets as necessary)

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Examiner Initials *	Cite No.1	U.S. Patent Document Number Kind Code 2 (if known)		Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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-3/0-	AB	3,658,586	WANG	04/25/1972	
<del>-  </del>	AC	3,796,597	V.R. PORTER, et al.	03/12/1974	
	AD	4,177,321	NISHIZAWA	12/04/1979	
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av	AL	EP	0 148 656	A1	AUZEL, et al.	11/16/1984		卩
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W AV		YUMASHEV K.V.,et al., "Co <sup>24</sup> -doped spinels saturable absorber Q-switches for 1.3-1.6 µm solid state lasers", OSA TRENDS IN OPTCS AND PHOTONICS. ADVANCED SOLID STATE LASERS., Vol. 34, pp. 236-239, 2000. XP008017966	
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Application Numb r NEW APPLICATION Filing Date HEREWITH First Nam d Inventor Milan R. Kokta Attorney Docket Number 1035-Bl3918-CIP

Sheet 2 of 3 (use as many sheets as necessary)

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<u> </u>	BB	4,627,064		AUZEL, et al.	12/02/1986	
<del></del>	BC	4,000,977		FALCKENBERG	01/04/1977	
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Examiner Initials *	Cite No.1	Title of Publication	Date of Publication of Cited Document MM-DD-YYYY
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<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

<sup>1</sup> Unique citation designation number. 2 See attached Kinds of U.S. Patent Documents, 3 Enter Office that issued the document, by the twoletter code (WIPO Standard ST.3). 4 For Japanese patent documents, the Indication of the year of the reign of the Emperor must precede the serial number of the patent document. 5 Kind of document by the appropriate symbols as Indicated on the document under WIPO Standard ST. 16 if possible. 6 Applicant is to place a check mark here if English language Translation is attached.

## INFORMATION DISCLOSURE STATEMENT BY APPLICANT

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Application Number NEW APPLICATION Filing Dat HEREWITH First Named Inv ntor Milan R. K kta Attorney Docket Number 1035-BI3918-CIP

Sheet 3 of 3

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## INFORMATION DISCLOSURE STATEMENT BY APPLICANT

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Sheet 1 of 1 (use as many sheets as necessary)

Complete if Known
Applicati n Number 10/669,145
Filing Date Septemb r 23, 2003
First Nam d Inventor Milan R. Kokta
Group Art Unit
Examiner Name
Attorney Docket Number 1035-BI3918-CIP

#### **U.S. PATENT DOCUMENTS**

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Examiner Initials *	Cite No.1	U.S. Patent Document Number Kind Code 2 (if known)	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
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Signature		James Va	amucci	Considered	7-12-05
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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

 Application Number
 10/669,145

 Filing Date
 September 23, 2003

 First Named Inventor
 Milan R. Kokta

 Art Unit
 2828

 Examiner Name
 Minsun Oh Harvey

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Sheet 1 of 3

Substitute for form 1449/PTO

Attorney Docket Number 1035-BI3918-CIP

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1	AB	<sup>US-</sup> 3,736,158	05/29/1973	Cullen et al.		
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_	AH	US- 4,370,739	01/25/1983	Wang et al.		
	Al	<sup>US-</sup> 4,755,314	07/05/1988	Sakaguchi et al.		
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L	AL	<sup>US-</sup> 6,533,874 B1	03/18/2003	Vaudo et al.		
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9~	AT	FR 1,471,976	03/24/1966	Siemens Aktiengesellsc.	Corr. 3,424,955	Г
<del>-</del>	AU	JP 11-157997	06/15/1999	Kyocera Corporation	Abstract Only	
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					First Named Inventor	Milan R. Kokta
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	Sheet	2	of	3	Attorney Docket Number	1035-BI3918-CIP

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W_	ВТ	EP 0 762 930 B1	07/12/2000	BP Amoco Corporation		
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//	BV	WO 01/99155 A2	12/27/2001	Nichia Corporation		
<del>\</del>	BW	WO 02/95887 A2	11/28/2002	SG Ceramics & Plastics Inc.	<i></i> .	
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				Application Number	10/669,145	
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Sheet	3	of	3	Attorney Docket Number	1035-BI3918-CIP	

		NON PATENT LITERATURE DOCUMENTS				
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	CD	Wyon et al., "Czochralski Growth and Optical Properties of Magnesium-Aluminum Spinel Doped with Nickel", JOURNAL OF CRYSTAL GROWHT, NORTH-HOLLAND PUBLISHING CO. AMSTERDAM, NL, Vol. 79, no. 1-3, part 2, 1986, pgs 710-713, XP-002250057.				
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# INFORMATION DISCLOSURE STATEMENT BY APPLICANT

Substitute for form 1449/PTO

Sheet 1

(Use as many sheets as necessary)

Col	Complete if Known							
Application Number	10/669,145							
Filing Date	September 23, 2003							
First Named Inventor	Milan R. Kokta							
Art Unit	2828							
Examiner Name	Minsun Oh Harvey							
Attorney Docket Number	1035-BI3918-CIP							

			U. S. PATENT	DOCUMENTS	_
Examiner Initials*	Cite No. <sup>1</sup>	Document Number  Number-Kind Code <sup>2 (F known)</sup>	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
W	Α	<sup>US-</sup> 3,808,065	04-30-1974	Robinson, et al.	
	В	<sup>US-</sup> 3,898,051	08-05-1975	Schmid	-
	С	US- 4,347,210	08-31-1982	Maguire, et al.	
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		FORE	IGN PATENT DOCU	MENTS		
Examiner Initials*	Cite No.1	Foreign Patent Document	Publication Date	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages Or Relevant Figures Appear	
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Sheet

INFORMATION DISCLOSURE STATEMENT BY APPLICANT

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Complete if Known

Application Number 10/669,145

Filing Date September 23, 2003

First Named Inventor Milan R. Kokta

Art Unit 4775

Examiner Name UNASSIGNED

Attorney Docket Number 1035-BI3918-CIP

			U. S. PATEN	DOCUMENTS	· · · · · · · · · · · · · · · · · · ·
Examiner Initials*	Cite No.1	Document Number  Number-Kind Code <sup>2 (f Innert)</sup>	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
90	AA	<sup>US-</sup> 4,963,520	10/16/1990	Yoo, et al.	
	AB	<sup>US-</sup> 5,982,796	11/09/1999	Kokta, et al.	
	AC	US- 5,654,973	08/05/1997	Stultz, et al.	
	AD	<sup>US-</sup> 5,557,624	09/17/1996	Stultz, et al.	
	AE	<sup>US-</sup> 6,366,596	04/02/2002	Yin, et al.	
V	AF	<sup>US-</sup> 6,023,479	02/08/2000	Thony, et al.	
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	AM	US-			
	AN	US-			
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	AQ	US-			
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	AS	US-			

		FOREI	<b>GN PATENT DOCU</b>	MENTS		
Examiner Initials*	Cite No.1	Foreign Patent Document	Publication Date	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages	
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Substitute for form 1449/PTO				Complete if Known		
				Application Number	10/669,145	
			CLOSURE	Filing Date	September 23, 2003	
STATEMENT BY APPLICANT First Named Inventor Milan R. Kokta			Milan R. Kokta			
(Use as many sheets as necessary)				Art Unit	1775 2828	
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Sheet	2	of	3	Attorney Docket Number	1035-BI3918-CIP	

		NON PATENT LITERATURE DOCUMENTS	
Examiner Cite Include name of the author (in CAPITAL LETTERS), title of the Initials* No. the item (book, magazine, journal, serial, symposium, catalog		Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T <sup>2</sup>
Efimov, A.N., et al., "Onan Unusual Azimuthal Orientation Relationship in the System Gallium Nitride Layer on Spinel Substrate", CRYSTALLOGRAPHY REPORTS, 45(2): 312-317 (2000).			
	вв	Sun C.J., et al., "Mg-doped green light emitting diodes over cubic (1 1 1) MgAl2O4 substrate", APP. PHYS. LETT. 72(19): 2361-2363 (1998).	
	вс	Efimov, A.N., et al., "Symmetry constraints and epitaxial growth on non-isomorphic substrate", THIN SOLID FILMS 260: 111-117 (1995).	_
	BD	George, T., et al., "Novel symmetry in the growht of gallim nitride on magnesium aluminate substrates", APPL. PHYS. LETT. 68(3): 337-339 (1996).	
	BE	Sun C.J., et al., "Deposition of high quality wurtzite GaN films over cubic (1 1 1) MgAl2O4 substrates using low pressure and metalorganic chemical vapor deposition, " APPL. PHYS. LETT. 68(8): 1129-1131 (1996).	_
	BF	Nakamura, S., et al., "Characteristics of InGaN multi-quantum-well-structure laser diodes, " APPL. PHYS. LETT. 68(23): 3269-3271 (1996).	
	ВG	Khan, M.A., et al., "Cleaved cavity optically pumped InGaN-GaN laser grown on spinel substrates," APPL. PHYS. LETT. 69(16): 2418-2420 (1996).	
	вн	Tempel, A., et al., "Nachweis von Stapelfehlem in GaN-Exitaxieschichten mittels Elecktronenbeugung," KRISTALL UND TECHNIK 10(7): 741-746 (1975).	
	, Bi	Tempel, A., et al., "Zur Epitaxie von Galliumnitride auf nichtstoechiometrischem Spinell im System GaC1/NH3/He, " KRISTALL UND TECHNICK 10(7): 747-758 (1975)	/
V	ВЈ	K.V. Yumashev, "Saturable absorber Co2+: MgAl2O3 crystal for Q switching of 1.34-um Nd3+: YAIO3 and 1.54-um Er3+: glass lasers," APPLIED OPTICS 38(30): 6343-6346 (1999).	_

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Substitute for form 1449/PTO			Complete if Known		
,			Application Number	10/669,145	
INFORMATI	ON DIS	CLOSURE	Filing Date	September 23, 2003	
STATEMEN	T BY A	PPLICANT	First Named Inventor Milan R. Kokta		
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(Use as many sheets as necessary)		Examiner Name	UNASSIGNED		
Sheet 3	of	3	Attorney Docket Number	1035-BI3918-CIP	

		NON PATENT LITERATURE DOCUMENTS	
Examiner Initials*	iner   Cite   Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of		T <sup>2</sup>
X	Camargo, M.B., et al., "Co2+ Y3Sc2Ga3O12 (YSGG) Passive Q-Switch for Infared Erbium Lasers," submitted to LEOS in 1994.		-
	СВ	Mikhailov, V.P., et al., "Passive Q-switch performance at 1.3u (1.5u) and nonlinear spectroscopy of Co2+: MgAl2O4 and Co2+: LaMgAl11O9 cyrstals," OSA TOPS VOL. 26 Advanced Solid-State Lasers, pp. 317-324 (1999).	_
	СС	Stulz, R.D., et al., "Diavalent Uranium and Cobalt Saturable Absorber Q-Switches at 1.5um," OSA Proceedings on Advanced Solid-State Lasers, 24:460-464 (1995).	
	CD	Bimbaum, M., et al., "Co2+: ZnSe Saturable Absorber Q-Switch for the 1.54 Um Er3+: Yb3+: Glass Laser, "OSA TOPS Vol. 10 Advanced Solid State Lasers, pp. 148-151 (1997).	_
	CE	Machida, H., et al., "difficulties encoutered during the Czochralxki growth of TiO2 single crystals," JOURNAL OF CYRSTAL GROWTH, 112: 835-837 (1997).	_
	CF	Camargo, M.B., et al., "Broad-band 1.54 um Saturable Absorber Q-switch with Co2+, " submitted to ASSL in 1995.	./
$\rightarrow$	CG	Yumashev, K.V., et al., "Nonlinear spectroscopy and passive Q-switching operation of a Co2+: LaMgAl11O19 crystal," J. OPT. SOC. AM. B., 16(12): 2189-2194 (1999).	
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